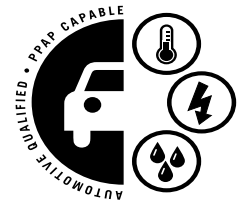


# E3M0060065K

Silicon Carbide Power MOSFET  
E-Series Automotive  
N-Channel Enhancement Mode



## Features

- 3rd generation SiC MOSFET technology
- Optimized package with separate driver source pin
- 8mm of creepage distance between drain and source
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery ( $Q_{rr}$ )
- Halogen free, RoHS compliant
- Automotive Qualified (AEC-Q101) and PPAP Capable

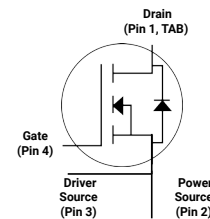
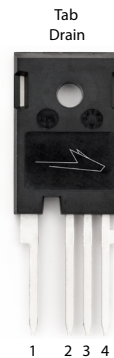
## Benefits

- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

## Applications

- EV Battery Chargers
- High Voltage DC/DC Converters

## Package



Part Number	Package	Marking
E3M0060065K	TO-247-4L	E3M0060065K

## Maximum Ratings ( $T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Note	
$V_{DSmax}$	Drain - Source Voltage	650	V		
$V_{GSmax}$	Gate - Source Voltage	-8/+19	V	Note: 1	
$I_D$	Continuous Drain Current, $V_{GS} = 15\text{ V}$	$T_c = 25^\circ\text{C}$	37	A	Fig. 19 Note: 2
		$T_c = 100^\circ\text{C}$	26		
$I_{D(pulse)}$	Pulsed Drain Current, Pulse width $t_p$ limited by $T_{jmax}$	99	A	Fig. 22	
$P_D$	Power Dissipation, $T_c=25^\circ\text{C}$ , $T_j = 175^\circ\text{C}$	131	W	Fig. 20 Note: 2	
$T_j, T_{stg}$	Operating Junction and Storage Temperature	-40 to +175	$^\circ\text{C}$		
$T_L$	Solder Temperature, 1.6mm (0.063") from case for 10s	260	$^\circ\text{C}$		
$M_d$	Mounting Torque, M3 or 6-32 screw	1	Nm		
		8.8	lbf-in		

Note (1): Recommended turn off / turn on gate voltage  $V_{GS} = -4V..0V / +15V$

Note (2): Verified by design

Electrical Characteristics ( $T_c = 25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	650			V	$V_{GS} = 0\text{ V}, I_D = 100\ \mu\text{A}$	
$V_{GS(th)}$	Gate Threshold Voltage	1.8	2.8	3.6	V	$V_{DS} = V_{GS}, I_D = 3.6\ \text{mA}$	Fig. 11
			2.2		V	$V_{DS} = V_{GS}, I_D = 3.6\ \text{mA}, T_J = 175^\circ\text{C}$	
$I_{DSS}$	Zero Gate Voltage Drain Current		1	50	$\mu\text{A}$	$V_{DS} = 650\ \text{V}, V_{GS} = 0\ \text{V}$	
$I_{GSS}$	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15\ \text{V}, V_{DS} = 0\ \text{V}$	
$R_{DS(on)}$	Drain-Source On-State Resistance		60	79	m $\Omega$	$V_{GS} = 15\ \text{V}, I_D = 13.2\ \text{A}$	Fig. 4, 5, 6
			83			$V_{GS} = 15\ \text{V}, I_D = 13.2\ \text{A}, T_J = 175^\circ\text{C}$	
$g_{fs}$	Transconductance		9		S	$V_{DS} = 20\ \text{V}, I_{DS} = 13.2\ \text{A}$	Fig. 7
			9			$V_{DS} = 20\ \text{V}, I_{DS} = 13.2\ \text{A}, T_J = 175^\circ\text{C}$	
$C_{iss}$	Input Capacitance		1170		pF	$V_{GS} = 0\ \text{V}, V_{DS} = 0\ \text{V to } 600\ \text{V}$ $F = 1\ \text{MHz}$ $V_{AC} = 25\ \text{mV}$	Fig. 17, 18
$C_{oss}$	Output Capacitance		72				
$C_{rss}$	Reverse Transfer Capacitance		6				
$E_{oss}$	$C_{oss}$ Stored Energy		14		$\mu\text{J}$		Fig. 16
$C_{o(er)}$	Effective Output Capacitance (Energy Related)		85		pF	$V_{GS} = 0\ \text{V}, V_{DS} = 0\ \dots\ 400\ \text{V}$	Note: 3
$C_{o(tr)}$	Effective Output Capacitance (Time Related)		122				
$E_{oN}$	Turn-On Switching Energy (External Diode)		29		$\mu\text{J}$	$V_{DS} = 400\ \text{V}, V_{GS} = -4\ \text{V}/15\ \text{V}, I_D = 13.2\ \text{A},$ $R_{G(ext)} = 2.5\ \Omega, L = 135\ \mu\text{H}, T_J = 175^\circ\text{C}$ FWD = External SiC DIODE	Fig. 25
$E_{oOFF}$	Turn Off Switching Energy (External Diode)		12				
$E_{oN}$	Turn-On Switching Energy (Body Diode FWD)		40		$\mu\text{J}$	$V_{DS} = 400\ \text{V}, V_{GS} = -4\ \text{V}/15\ \text{V}, I_D = 13.2\ \text{A},$ $R_{G(ext)} = 2.5\ \Omega, L = 135\ \mu\text{H}, T_J = 175^\circ\text{C}$ FWD = Internal Body Diode	Fig. 25
$E_{oOFF}$	Turn-Off Switching Energy (Body Diode FWD)		11				
$t_{d(on)}$	Turn-On Delay Time		9		ns	$V_{DD} = 400\ \text{V}, V_{GS} = -4\ \text{V}/15\ \text{V}$ $I_D = 13.2\ \text{A}, R_{G(ext)} = 2.5\ \Omega,$ Timing relative to $V_{DS}$ Inductive load	Fig. 26
$t_r$	Rise Time		10				
$t_{d(off)}$	Turn-Off Delay Time		16				
$t_f$	Fall Time		8				
$R_{G(int)}$	Internal Gate Resistance		4		$\Omega$	$f = 1\ \text{MHz}, V_{AC} = 25\ \text{mV}$	
$Q_{gs}$	Gate to Source Charge		16		nC	$V_{DS} = 400\ \text{V}, V_{GS} = -4\ \text{V}/15\ \text{V}$ $I_D = 13.2\ \text{A}$ Per IEC60747-8-4 pg 21	Fig. 12
$Q_{gd}$	Gate to Drain Charge		16				
$Q_g$	Total Gate Charge		49				

Note (3):  $C_{o(er)}$ , a lumped capacitance that gives same stored energy as  $C_{oss}$  while  $V_{ds}$  is rising from 0 to 400V

$C_{o(tr)}$ , a lumped capacitance that gives same charging time as  $C_{oss}$  while  $V_{ds}$  is rising from 0 to 400V

Reverse Diode Characteristics ( $T_c = 25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$V_{SD}$	Diode Forward Voltage	4.6		V	$V_{GS} = -4\text{ V}, I_{SD} = 6.6\text{ A}, T_J = 25^\circ\text{C}$	Fig. 8, 9, 10
		4.1		V	$V_{GS} = -4\text{ V}, I_{SD} = 6.6\text{ A}, T_J = 175^\circ\text{C}$	
$I_S$	Continuous Diode Forward Current		23	A	$V_{GS} = -4\text{ V}, T_C = 25^\circ\text{C}$	
$I_{S,pulse}$	Diode pulse Current		99	A	$V_{GS} = -4\text{ V}$ , pulse width $t_p$ limited by $T_{Jmax}$	
$t_{rr}$	Reverse Recover time	12		ns	$V_{GS} = -4\text{ V}, I_{SD} = 13.2\text{ A}, V_R = 400\text{ V}$ $dif/dt = 4770\text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$	
$Q_{rr}$	Reverse Recovery Charge	173		nC		
$I_{rrm}$	Peak Reverse Recovery Current	28		A		
$t_{rr}$	Reverse Recover time	15		ns	$V_{GS} = -4\text{ V}, I_{SD} = 13.2\text{ A}, V_R = 400\text{ V}$ $dif/dt = 2200\text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$	
$Q_{rr}$	Reverse Recovery Charge	122		nC		
$I_{rrm}$	Peak Reverse Recovery Current	13		A		

## Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	1.02	1.14	$^\circ\text{C}/\text{W}$		Fig. 21



Typical Performance

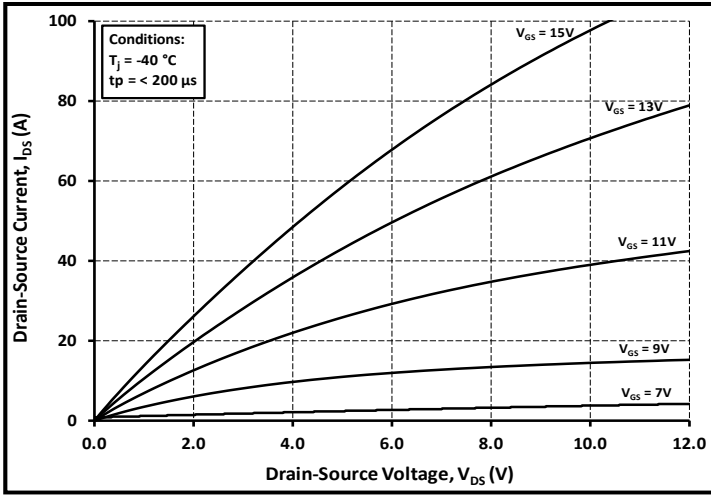


Figure 1. Output Characteristics  $T_j = -40\text{ }^\circ\text{C}$

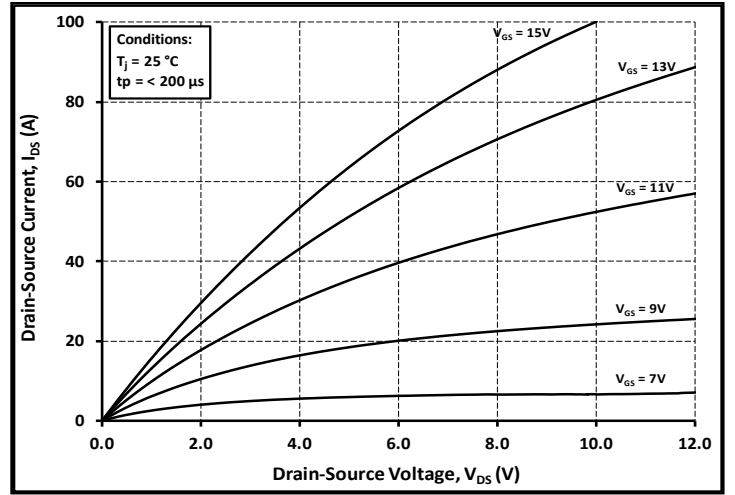


Figure 2. Output Characteristics  $T_j = 25\text{ }^\circ\text{C}$

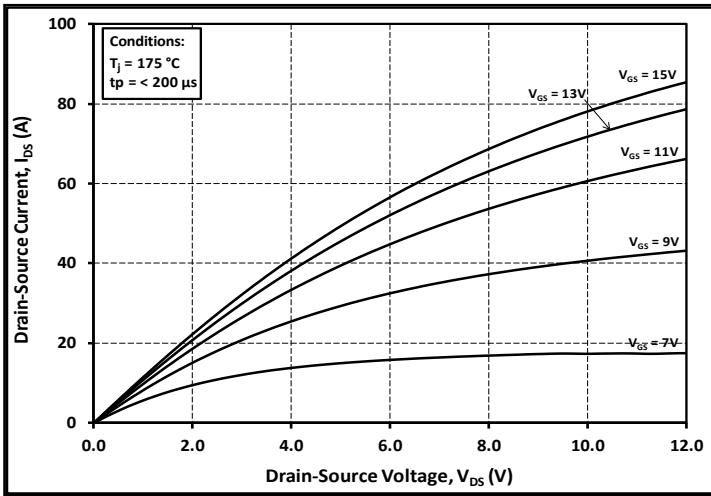


Figure 3. Output Characteristics  $T_j = 175\text{ }^\circ\text{C}$

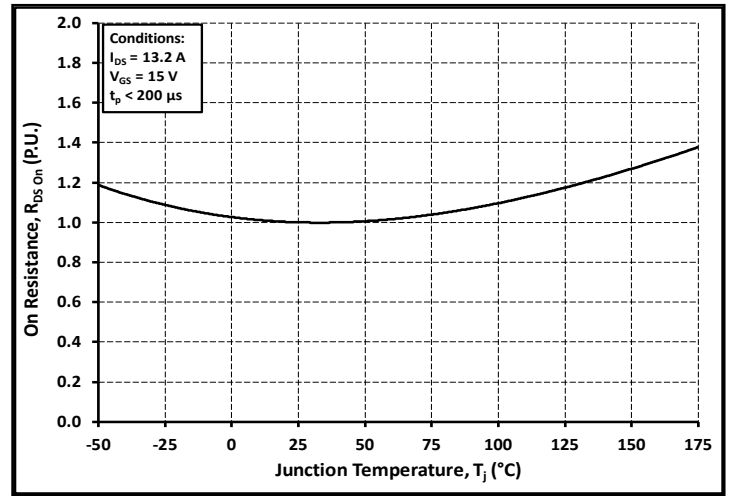


Figure 4. Normalized On-Resistance vs. Temperature

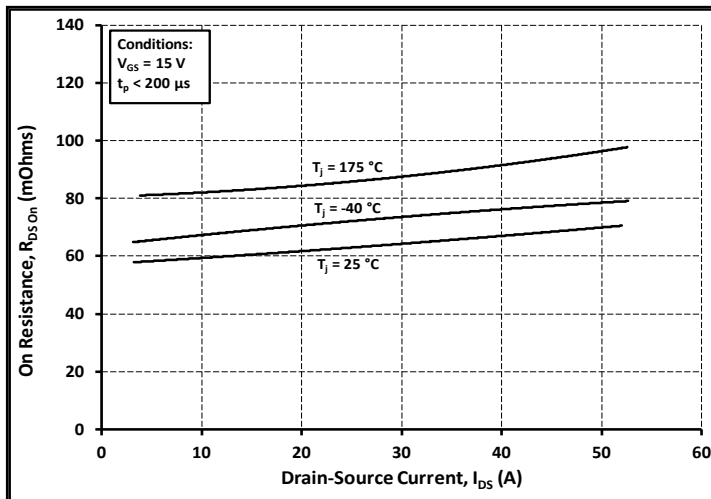


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

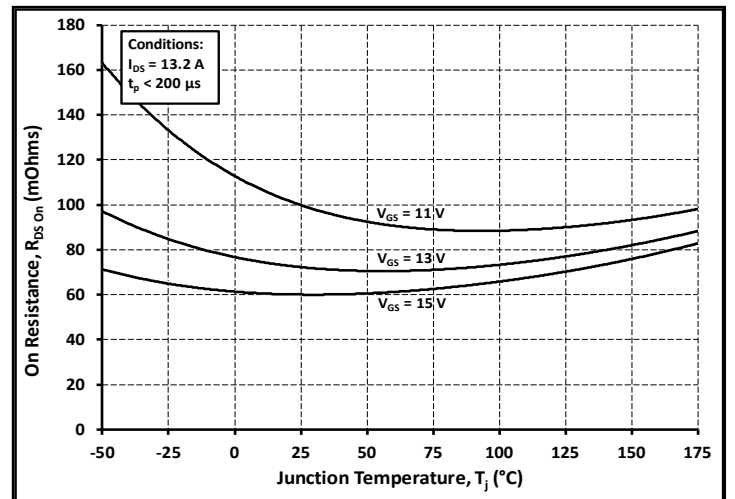


Figure 6. On-Resistance vs. Temperature For Various Gate Voltage



Typical Performance

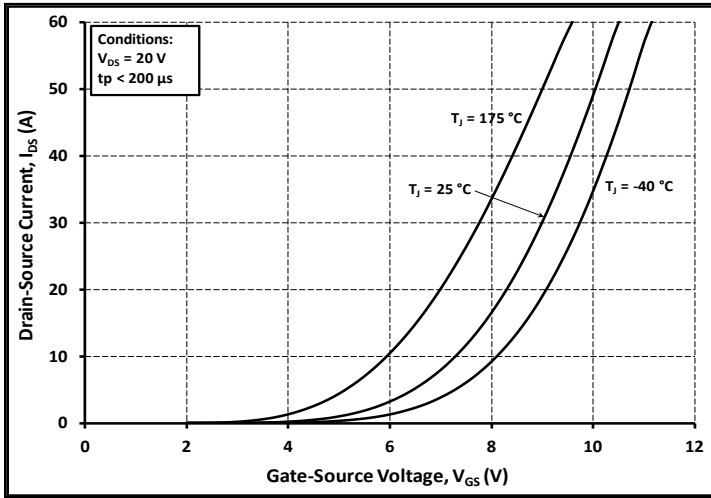


Figure 7. Transfer Characteristic for Various Junction Temperatures

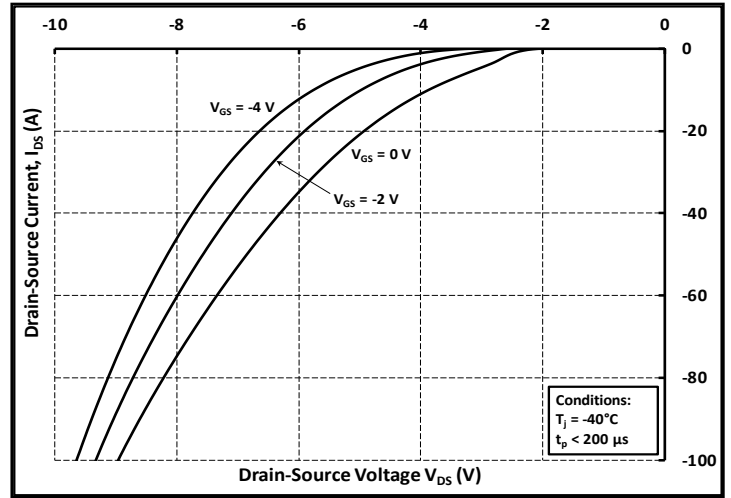


Figure 8. Body Diode Characteristic at -40 °C

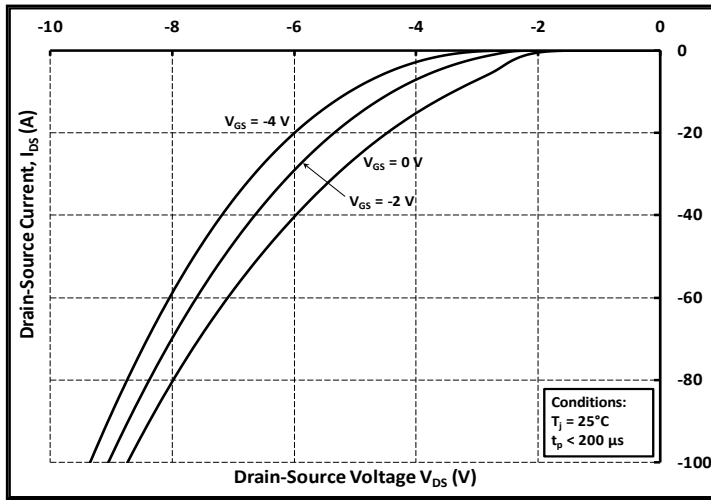


Figure 9. Body Diode Characteristic at 25 °C

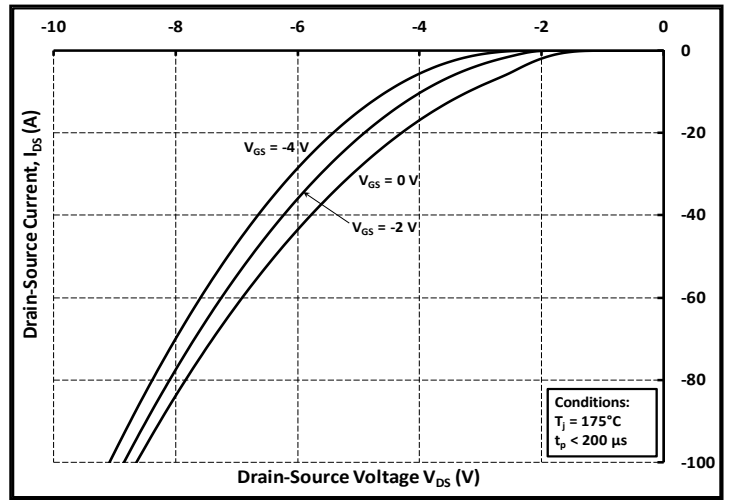


Figure 10. Body Diode Characteristic at 175 °C

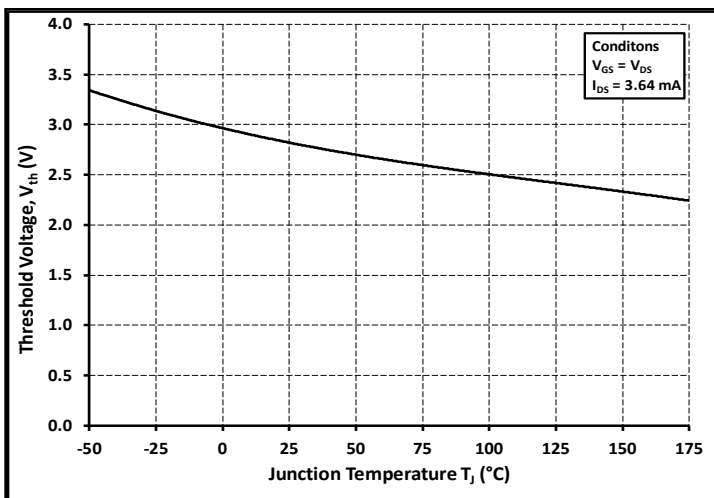


Figure 11. Threshold Voltage vs. Temperature

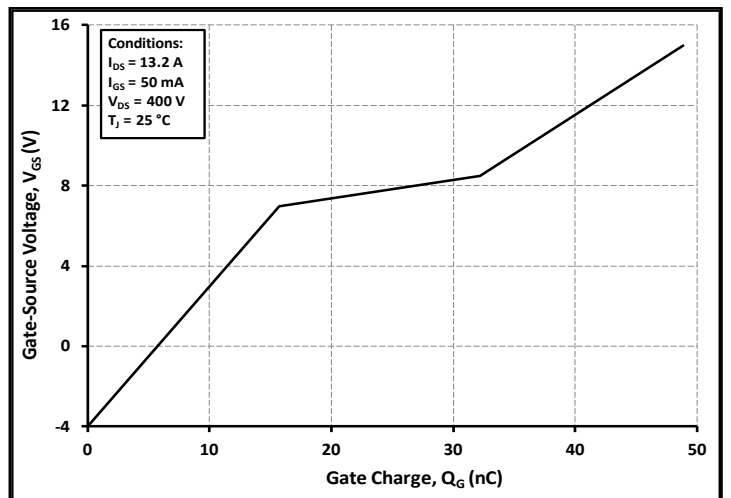


Figure 12. Gate Charge Characteristics



Typical Performance

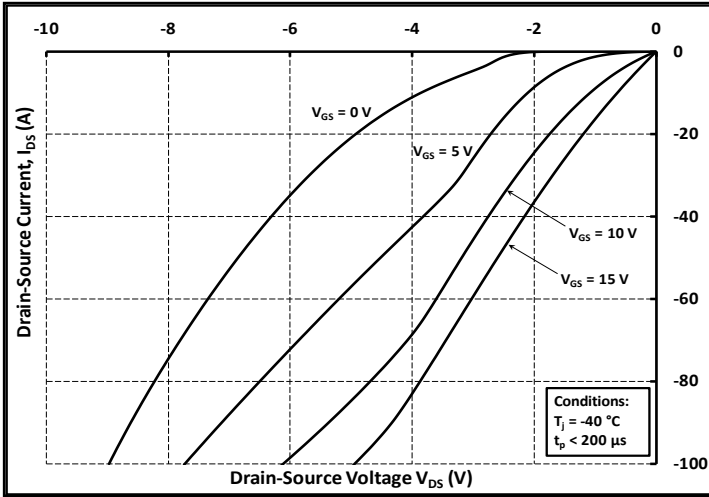


Figure 13. 3rd Quadrant Characteristic at  $-40\text{ }^\circ\text{C}$

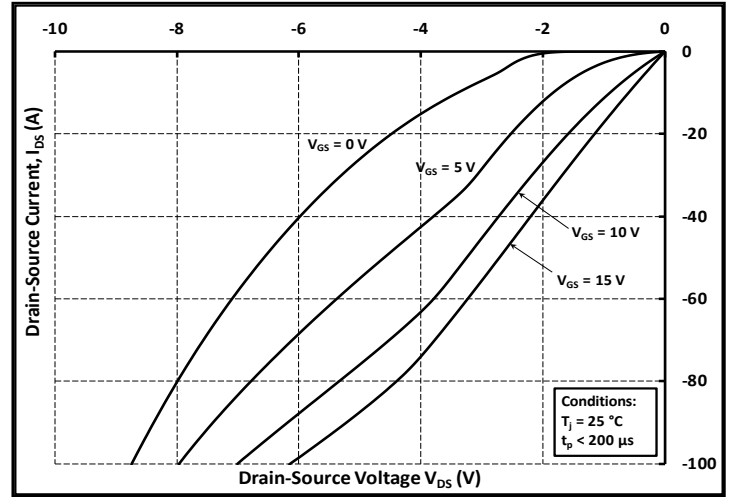


Figure 14. 3rd Quadrant Characteristic at  $25\text{ }^\circ\text{C}$

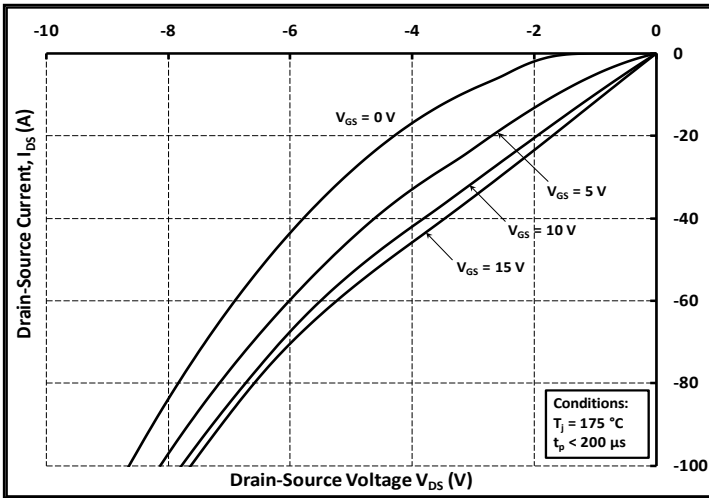


Figure 15. 3rd Quadrant Characteristic at  $175\text{ }^\circ\text{C}$

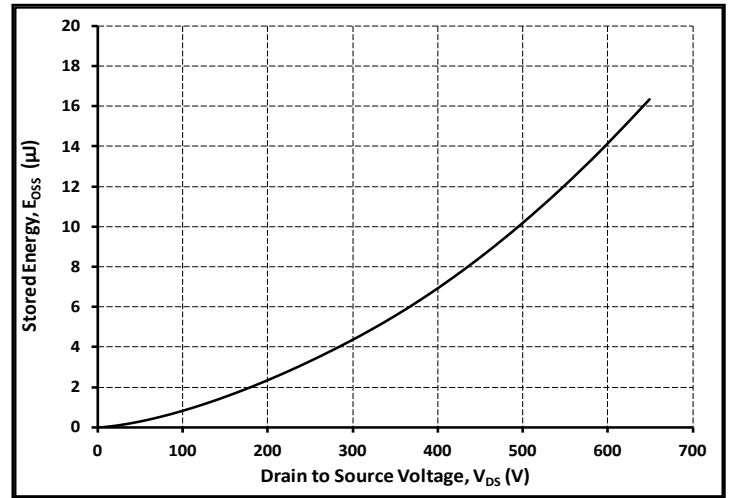


Figure 16. Output Capacitor Stored Energy

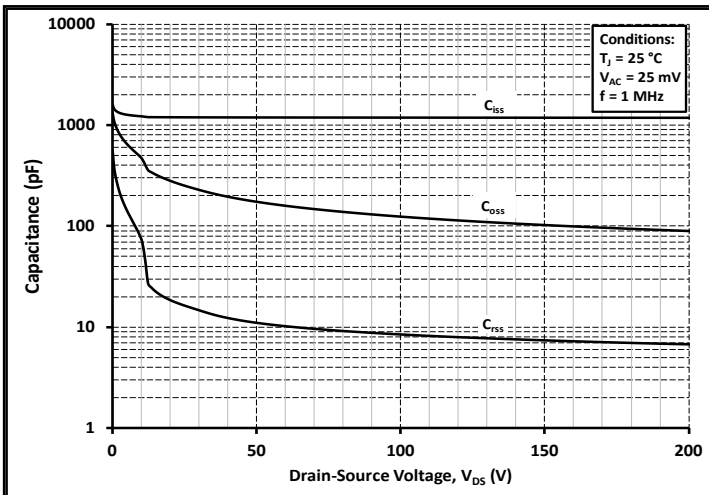


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

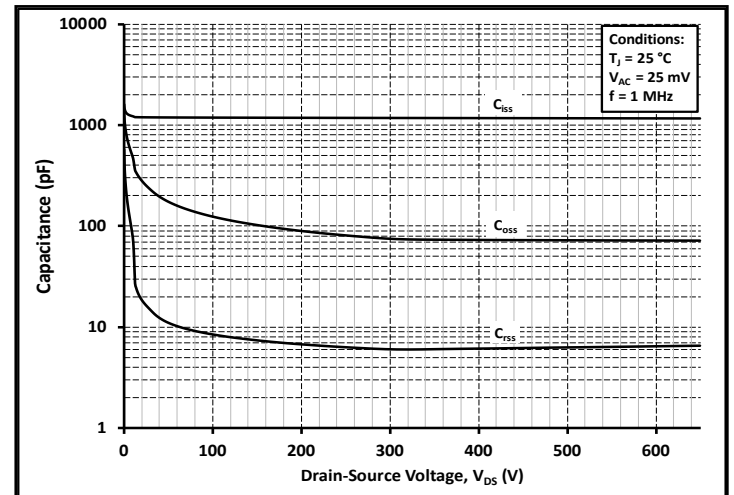


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 650V)



Typical Performance

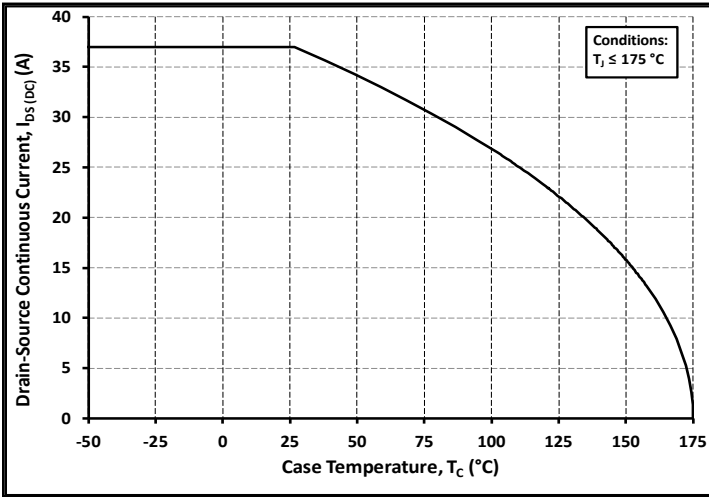


Figure 19. Continuous Drain Current Derating vs. Case Temperature

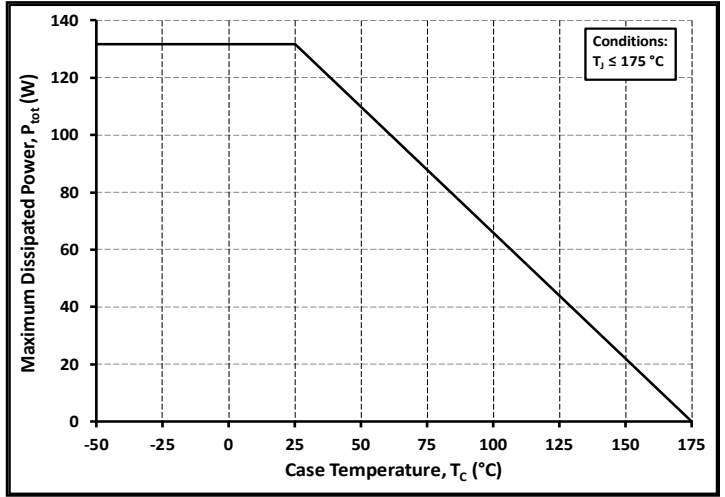


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

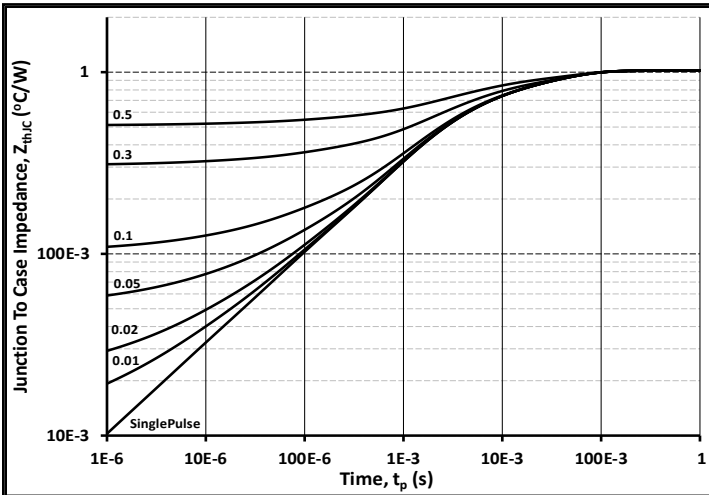


Figure 21. Transient Thermal Impedance (Junction - Case)

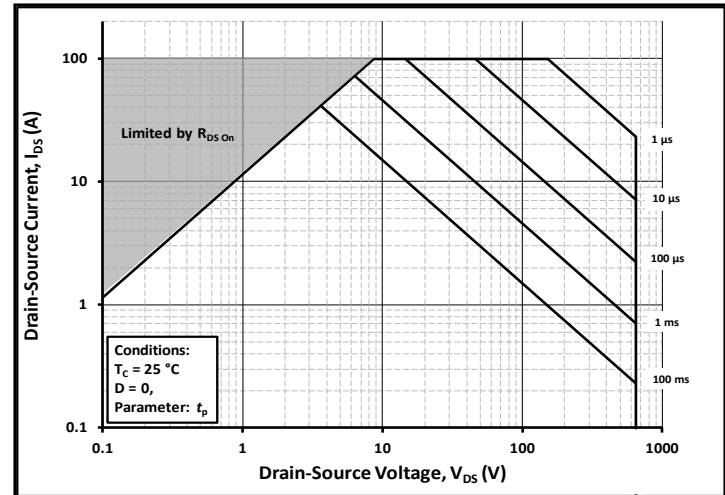


Figure 22. Safe Operating Area

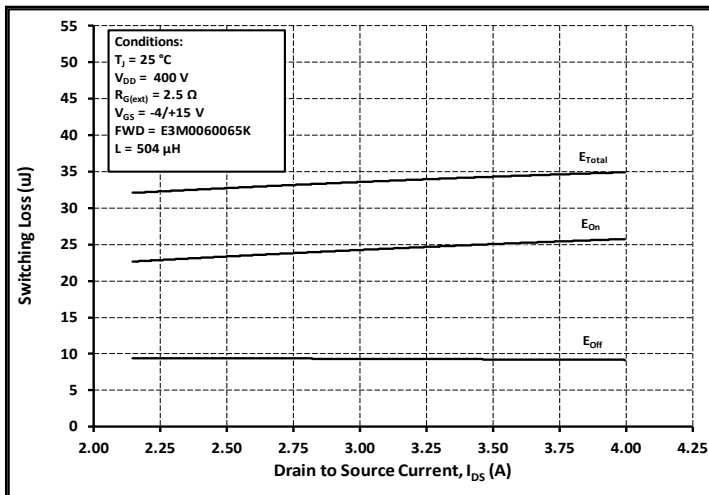


Figure 23. Clamped Inductive Switching Energy vs. Low Drain Current ( $V_{DD} = 400V$ )

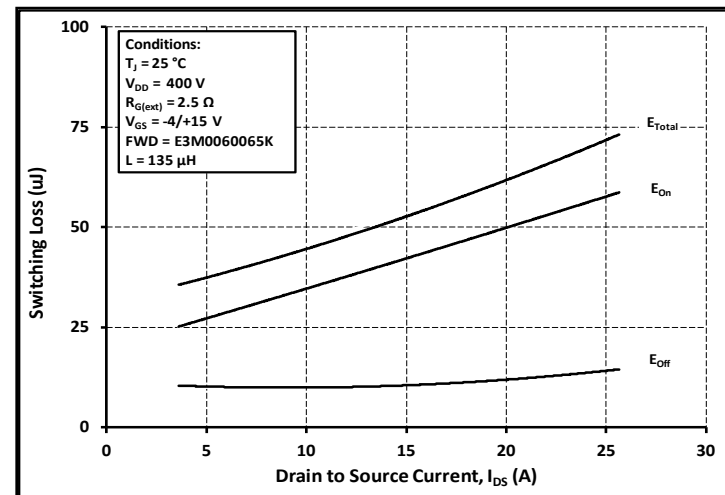


Figure 24. Lamped Inductive Switching Energy vs. High Drain Current ( $V_{DD} = 400V$ )



Typical Performance

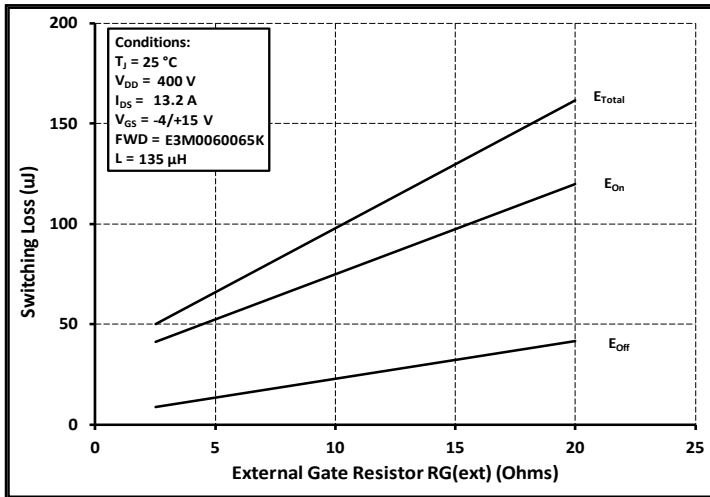


Figure 25. Clamped Inductive Switching Energy vs.  $R_{G(\text{ext})}$

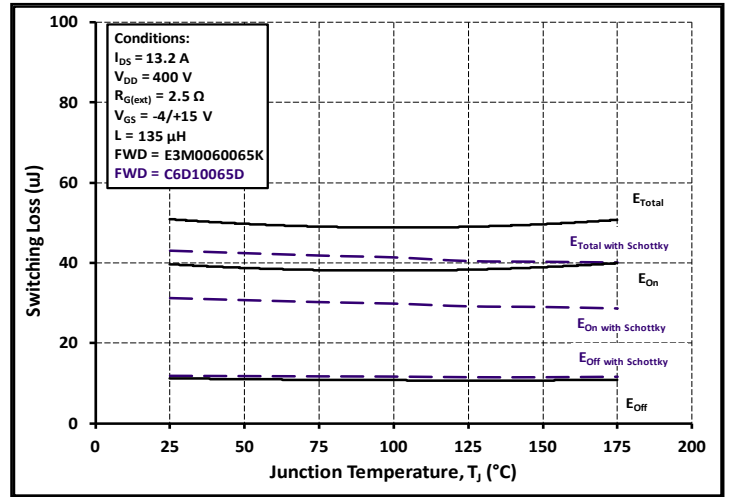


Figure 26. Clamped Inductive Switching Energy vs. Temperature

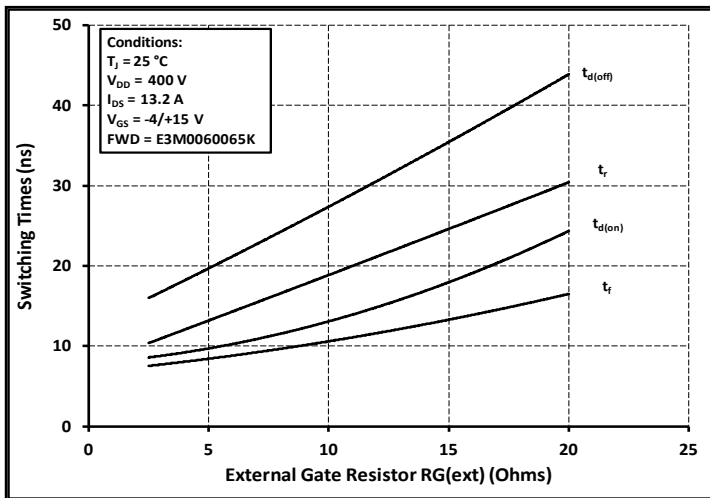


Figure 27. Switching Times vs.  $R_{G(\text{ext})}$

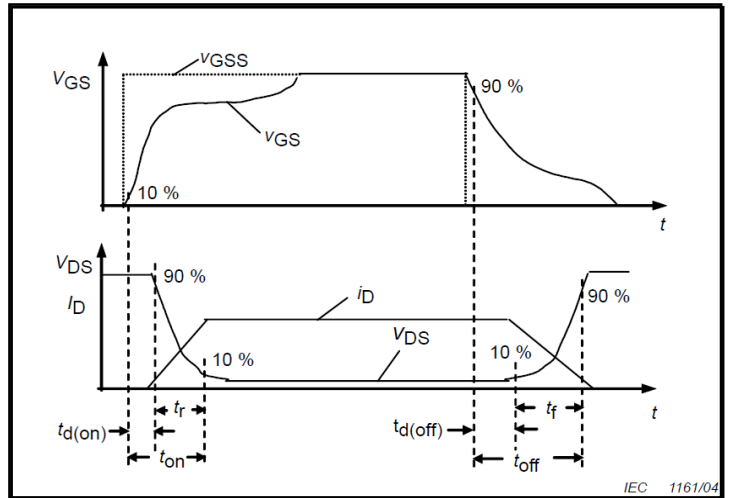


Figure 28. Switching Times Definition



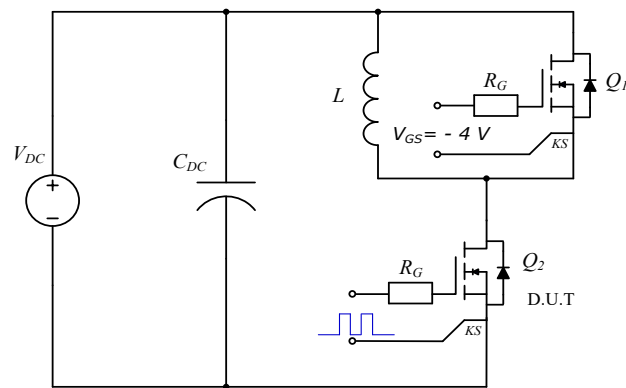
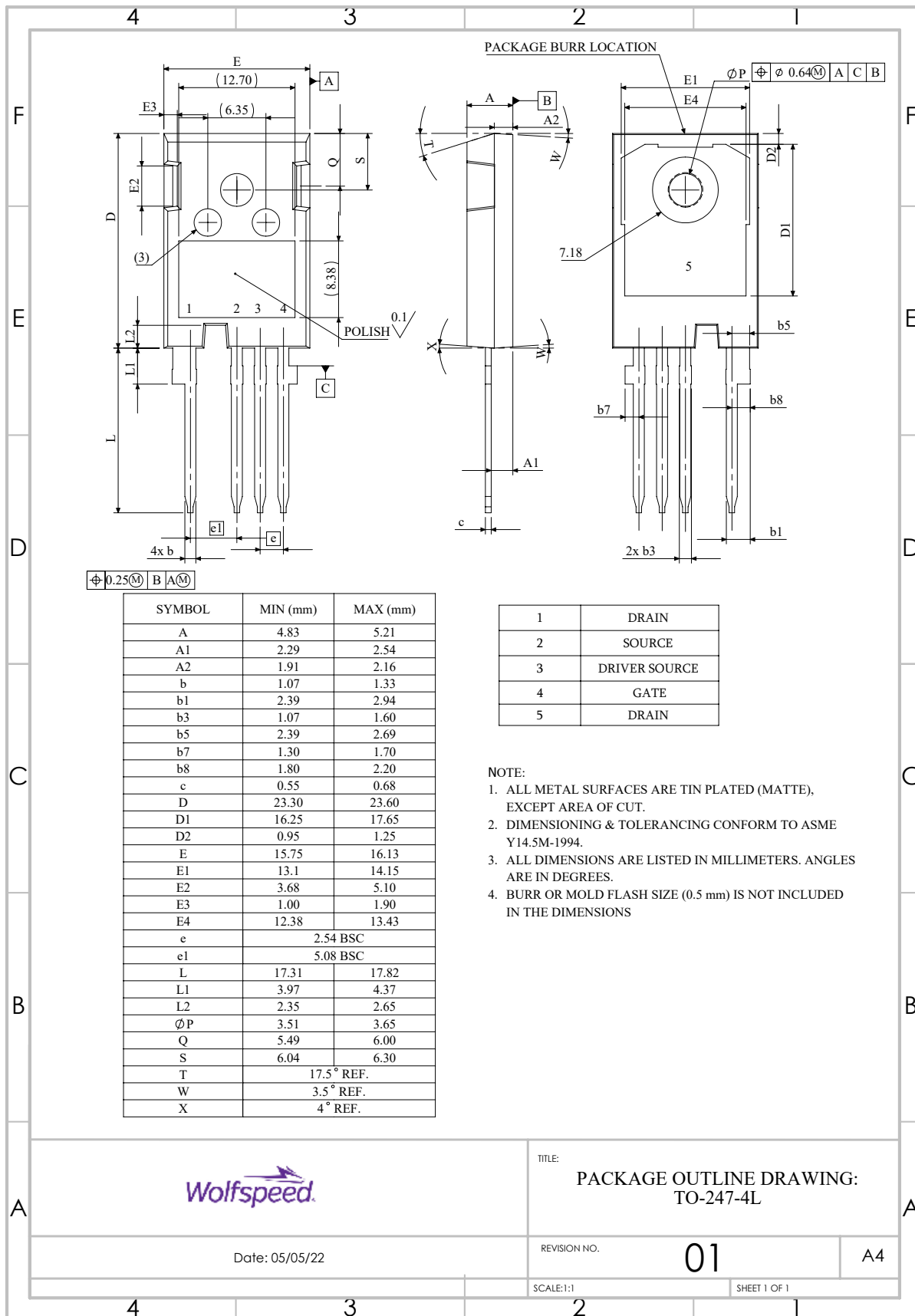
Test Circuit Schematic

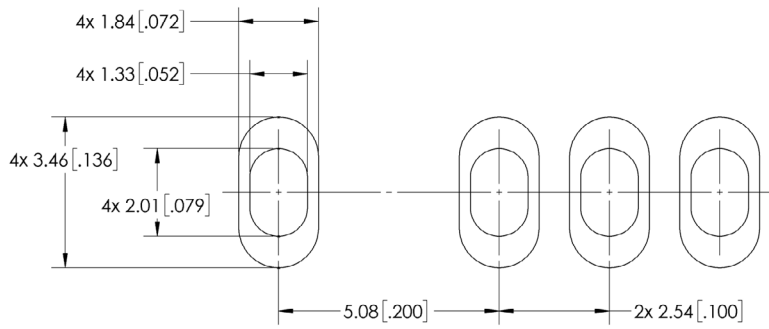
Figure 29. Clamped Inductive Switching  
Waveform Test Circuit

Package Dimensions





Recommended Solder Pad Layout





Revision history

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Document Version	Date of release	Description of changes
1.0	June-2022	Initial datasheet



## Notes & Disclaimer

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### Contact info:

4600 Silicon Drive  
Durham, NC 27703 USA  
Tel: +1.919.313.5300  
[www.wolfspeed.com/power](http://www.wolfspeed.com/power)